

S1L50000 SERIES HIGH DENSITY GATE ARRAY

■ DESCRIPTION

EPSON Electronics America, Inc.'s S1L50000 Series is a family of ultra high-speed VLSI CMOS gate array utilizing a 0.35μm "sea-of-gates" architecture. The S1L50000H products feature 5V tolerant I/O buffers.

- Ultra-high-speed, high density and low power consumption
- Low voltage operation: 3.3V and 2.0V
- Number of raw gates: 28,710 ~ 815,468 gates

■ FEATURES

- Process 0.35μm 2/3/4 layer metalization CMOS process
- Integration A maximum of 815,468 gates (2 input NAND gate equivalent)
- Operating Speed Internal gates: 140 ps (3.3V Typ), 210 ps (2.0V Typ)
(2-input pair NAND, F/O = 2, Typical wire load)
Input buffer: 380 ps (5.0V Typ) Built-in level shifter is used.
400 ps (3.3V Typ), 1.30 ns (2.0V Typ)
(F/O = 2, Typical wire load)
Output buffer: 2.12 ns (5.0V Typ) Built-in level shifter is used.
2.02 ns (3.3 V Typ), 3.90 ns (2.0V Typ)
(C_L = 15 pF)
- I/F Levels Input/Output TTL/CMOS/LVTTL compatible
- Input Modes TTL, CMOS, LVTTL, TTL Schmitt, CMOS Schmitt, LVTTL Schmitt, PCI
Built-in pull-up and pull-down resistors can be usable.
(2 types for each resistor value)
- Output Modes Normal, 3-state, bi-directional, PCI
- Output Drive I_{OL} = 0.1, 1, 3, 8, 12, 24 mA selectable
(Built-in level shifter is used at 5.0V)
I_{OL} = 0.1, 1, 2, 6, 12 mA selectable (at 3.3V)
I_{OL} = 0.05, 0.3, 0.6, 2, 4 mA selectable (at 2.0V)
- RAM Asynchronous 1-port, asynchronous 2-port
- Dual Power Operation supported by using level-shifter circuit
Internal logic: Operation supported by low voltage
I/O Buffer: Built-in interfaces of both high and low voltages possible
- Operation possible at V_{DD} = 2.0 ± 0.2V

■ **LINE UP**

The S1L50000 Series comprises 11 types of masters, from which the customer is able to select the master most suitable.

Master	Total BC (Raw Gates)	Number of Pads	Number of Columns (X)	Number of Rows (Y)	Cell Utilization Ratio (U) ^{*1}		
					2-layer metal	3-layer metal	4-layer metal
S1L50282/283/284	28710	88	319	90	50%	88%	95%
S1L50752/753/754	75774	144	519	146	47%	85%	95%
S1L50992/993/994	99198	168	594	167	47%	85%	95%
S1L51252/253/254	125772	188	669	188	45%	80%	95%
S1L51772/773/774	177062	224	794	223	45%	75%	95%
S1L52502/503/504	250160	264	944	265	45%	75%	95%
S1L53352/353/354	335858	308	1094	307	43%	75%	95%
S1L54422/423/424	442112	352	1256	352	40%	70%	90%
S1L55062/063/064	506688	376	1344	377	40%	70%	90%
S1L56682/683/684	668552	432	1544	433	40%	70%	90%
S1L58152/153/154	815468	480	1706	478	40%	70%	90%

NOTE: ¹: This is the value when there are no cells, such as RAM cells. The cell use efficiency is dependent not only on the scope of the circuits, but also on the number of signals, the number of branches per signal, etc.; thus, use the values in this table only as an estimate

■ ELECTRICAL CHARACTERISTICS AND SPECIFICATIONS

Absolute Maximum Ratings (For Single Power Supply):

($V_{ss} = 0V$)

Item	Symbol	Limits	Unit
Power Supply Voltage	V_{DD}	-0.3 to 4.0	V
Input Voltage	V_I	-0.3 to $V_{DD} + 0.5^{*1}$	V
Output Voltage	V_O	-0.3 to $V_{DD} + 0.5^{*1}$	V
Output Current/Pin	I_{OUT}	± 30	mA
Storage Temperature	T_{STG}	-65 to 150	°C

1: Possible to use from -0.3V to 7.5V of I/O buffer voltage in the open-drain systems and input buffer in the IDC and IDH systems.

Absolute Maximum Ratings (For Dual Power Supplies):

($V_{ss} = 0V$)

Item	Symbol	Limits	Unit
Power Supply Voltage	HV_{DD}	-0.3 to 7.0	V
	LV_{DD}	-0.3 to 4.0	V
Input Voltage	HV_I	-0.3 to $HV_{DD} + 0.5^{*1}$	V
	LV_I	-0.3 to $LV_{DD} + 0.5^{*1}$	V
Output Voltage	HV_O	-0.3 to $HV_{DD} + 0.5^{*1}$	V
	LV_O	-0.3 to $LV_{DD} + 0.5^{*1}$	V
Output Current/Pin	I_{OUT}	$\pm 30 (\pm 50^{*2})$	mA
Storage Temperature	T_{STG}	-65 to 150	°C

1: Possible to use from -0.3V to 7.5V of I/O buffer voltage in the open-drain systems and input buffer in the IDC and IDH systems.

*2: Possible to use for 24mA of output buffer.

Recommended Operating Conditions (For Single Power Supplies):

Item	Symbol	Min	Typ	Max	Unit
Power Supply Voltage	V _{DD}	3.00	3.30	3.60	V
Input Voltage	V _I	V _{SS}	--	V _{DD} ^{*1}	V
Ambient Temperature	T _a	0 -40	25 25	70 ^{*2} 85 ^{*3}	°C
Normal Input for Rising Edge Input	t _{ri}	--	--	50	ns
Normal Input for Falling Edge Input	t _{fi}	--	--	50	ns
Schmitt Input for Rising Edge Input	t _{ri}	--	--	5	ms
Schmitt Input for Falling Edge Input	t _{fi}	--	--	5	ms

*1: Possible to use 5.25 or 5.50V of I/O buffer in the open-drain systems and input buffer in the IDC and IDH systems.

*2: The ambient temperature range is recommended for T_j = 0 to 80°C

*3: The ambient temperature range is recommended for T_j = -40 to 125°C

Recommended Operating Conditions (For Single Power Supplies):

Item	Symbol	Min	Typ	Max	Unit
Power Supply Voltage	V _{DD}	1.80	2.00	2.20	V
Input Voltage	V _I	V _{SS}	--	V _{DD} ^{*1}	V
Ambient Temperature	T _a	0 -40	25 25	70 ^{*2} 85 ^{*3}	°C
Normal Input for Rising Edge Input	t _{ri}	--	--	100	ns
Normal Input for Falling Edge Input	t _{fi}	--	--	100	ns
Schmitt Input for Rising Edge Input	t _{ri}	--	--	10	ms
Schmitt Input for Falling Edge Input	t _{fi}	--	--	10	ms

*1: Possible to use 5.25 or 5.50V of I/O buffer in the open-drain systems and input buffer in the IDC and IDH systems.

*2: The ambient temperature range is recommended for T_j = 0 to 80°C

*3: The ambient temperature range is recommended for T_j = -40 to 125°C

Recommended Operating Conditions (For Dual Power Supplies):

Item	Symbol	Min	Typ	Max	Unit
Power Supply Voltage (High Voltage)	HV _{DD}	4.75 4.50	5.00 5.00	5.25 5.50	V
Power Supply Voltage (Low Voltage)	LV _{DD}	3.00	3.30	3.60	V
Input Voltage	HV _I	V _{SS}	--	HV _{DD}	V
	LV _I	V _{SS}	--	LV _{DD} ^{*1}	
Ambient Temperature	T _a	0 -40	25 25	70 ^{*2} 85 ^{*3}	°C
Normal Input for Rising Edge Input	tri	--	--	50	ns
Normal Input for Falling Edge Input	tri	--	--	50	ns
Schmitt Input for Rising Edge Input	tri	--	--	5	ms
Schmitt Input for Falling Edge Input	tri	--	--	5	ms

*1: Possible to use 5.25 or 5.50V of I/O buffer in the open-drain systems and input buffer in the LIDC and LIDH systems.

*2: The ambient temperature range is recommended for T_j = 0 to 80°C

*3: The ambient temperature range is recommended for T_j = -40 to 125°C

Recommended Operating Conditions (For Dual Power Supplies):

Item	Symbol	Min	Typ	Max	Unit
Power Supply Voltage (High Voltage)	HV _{DD}	3.00	3.30	3.60	V
Power Supply Voltage (Low Voltage)	LV _{DD}	1.80	2.00	2.20	V
Input Voltage	HV _I	V _{SS}	--	HV _{DD}	V
	LV _I	V _{SS}	--	LV _{DD}	
Ambient Temperature	T _a	0 -40	25 25	70 ^{*1} 85 ^{*2}	°C
Normal Input for Rising Edge Input	H _{tri}	--	--	50	ns
	L _{tri}	--	--	100	
Normal Input for Falling Edge Input	H _{tfi}	--	--	50	ns
	L _{tfi}	--	--	100	
Schmitt Input for Rising Edge Input	H _{tri}	--	--	5	ms
	L _{tri}	--	--	10	
Schmitt Input for Falling Edge Input	H _{tfi}	--	--	5	ms
	L _{tfi}	--	--	10	

*1: Possible to use 5.25 or 5.50V of I/O buffer in the open-drain systems and input buffer in the LIDC and LIDH systems or HIDC and HIDH systems.

*2: The ambient temperature range is recommended for T_j = 0 to 80°C

*3: The ambient temperature range is recommended for T_j = -40 to 125°C

Electrical Characteristics of the S1L50000 Series:(V_{DD} = 5.0V, V_{SS} = 0V, T_a = -40 to 85°C)

Item	Symbol	Conditions		Min	Typ	Max	Unit
Input Leakage Current	I _{LI}	--		-1	--	1	µA
Off State Leakage Current	I _{OZ}	--		-1	--	1	µA
High Level Output Voltage	V _{OH}	I _{OH} = -0.1mA (Type S), -1mA (Type M), -3mA (Type 1), -8mA (Type 2), -12mA (Type 3, Type 4) V _{DD} = Min	HV _{DD} -0.4	--	--	--	V
Low Level Output Voltage	V _{OL}	I _{OL} = 0.1mA (Type S), 1mA (Type M), 3mA (Type 1), 8mA (Type 2), 12mA (Type 3), 24mA (Type 4) V _{DD} = Min	--	--	0.4	--	V
High Level Input Voltage	V _{IH1}	CMOS Level, HV _{DD} = Max	3.5	--	--	--	V
Low Level Input Voltage	V _{IL1}	CMOS Level, HV _{DD} = Min	--	--	1.0	--	V
High Level Input Voltage	V _{T1+}	CMOS Schmitt	2.0	--	4.0	--	V
Low Level Input Voltage	V _{T1-}	CMOS Schmitt	0.8	--	3.1	--	V
Hysteresis Voltage	V _{H1}	CMOS Schmitt	0.3	--	--	--	V
High Level Input Voltage	V _{IH2}	TTL Level, HV _{DD} = Max	2.0	--	--	--	V
Low Level Input Voltage	V _{IL2}	TTL Level, HV _{DD} = Min	--	--	0.8	--	V
High Level Input Voltage	V _{T2+}	TTL Schmitt	1.2	--	2.4	--	V
Low Level Input Voltage	V _{T2-}	TTL Schmitt	0.6	--	1.8	--	V
Hysteresis Voltage	V _{H2}	TTL Schmitt	0.1	--	--	--	V
High Level Input Voltage	V _{IH3}	PCI Level, HV _{DD} = Max	2.0	--	--	--	V
Low Level Input Voltage	V _{IL3}	PCI Level, HV _{DD} = Min	--	--	0.8	--	V
High Level Output Current	I _{OH3}	PCI Response, V _{OH} = 1.4V, HV _{DD} = Min V _{OH} = 3.1V, HV _{DD} = Max	-44	--	--	-142	mA mA
Low Level Output Current	I _{OL3}	PCI Response V _{OH} = 2.20V, HV _{DD} = Min V _{OL} = 0.71V, HV _{DD} = Max	95	--	--	206	mA mA
Pull-up Resistance*	R _{PU}	V _I = 0V	Type 1	30	60	(120) 144	KΩ
			Type 2	60	120	(240) 288	
Pull-down Resistance*	R _{PD}	V _I = V _{DD}	Type 1	30	60	(120) 144	KΩ
			Type 2	60	120	(240) 288	
High Level Maintenance Current	I _{BHH}	Bus Hold Response, V _{IN} = 2.0V (TTL) HV _{DD} = Min	--	--	-80	--	µA
Low Level Maintenance Current	I _{BHL}	Bus Hold Response, V _{IN} = 0.8V (TTL) HV _{DD} = Min	--	--	33	--	µA
High Level Reversal Current	I _{BHHO}	Bus Hold Response, V _{IN} = 0.8V (TTL) HV _{DD} = Max	-550	--	--	--	µA
Low Level Reversal Current	I _{BHLO}	Bus Hold Response, V _{IN} = 2.0V (TTL) HV _{DD} = Max	330	--	--	--	µA
Input Terminal Capacitance	C _I	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF
Output Terminal Capacitance	C _O	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF
Input/Output Terminal Capacitance	C _{IO}	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF

* The values in parentheses are for the case of T_a = 0 to 70°C.

Electrical Characteristics of the S1L50000 Series:

($V_{DD} = 3.3V \pm 0.3V$, $V_{SS} = 0V$, $T_a = -40$ to 85°C)

Item	Symbol	Conditions		Min	Typ	Max	Unit
Quiescent Current*	I_{DDS}	Quiescent Conditions		--	--	170	μA
Input Leakage Current	I_{LI}	--		-1	--	1	μA
Off State Leakage Current	I_{LOZ}	--		-1	--	1	μA
High Level Output Voltage	V_{OH}	$I_{OH} = -0.1\text{mA}$ (Type S), -1mA (Type M), -2mA (Type 1), -6mA (Type 2), -12mA (Type 3, Type 4) $V_{DD} = \text{Min}$	$V_{DD} = -0.4$	--	--	--	V
Low Level Output Voltage	V_{OL}	$I_{OL} = 0.1\text{mA}$ (Type S), 1mA (Type M), 2mA (Type 1), 6mA (Type 2), 12mA (Type 3), 24mA (Type 4) $V_{DD} = \text{Min}$	--	--	0.4	--	V
High Level Input Voltage	V_{IH1}	LVTTL Level, $V_{DD} = \text{Max}$		2.0	--	--	V
Low Level Input Voltage	V_{IL1}	LVTTL Level, $V_{DD} = \text{Min}$		--	--	0.8	V
High Level Input Voltage	V_{T1+}	LVTTL Schmitt		1.1	--	2.4	V
Low Level Input Voltage	V_{T1-}	LVTTL Schmitt		0.6	--	1.8	V
Hysteresis Voltage	V_{H1}	LVTTL Schmitt		0.1	--	--	V
High Level Input Voltage	V_{IH3}	PCI Level, $V_{DD} = \text{Max}$		1.71	--	--	V
Low Level Input Voltage	V_{IL3}	PCI Level, $V_{DD} = \text{Min}$		--	--	0.98	V
High Level Output Current	I_{OH3}	I_{OH3} Response, $V_{OH} = 0.90\text{V}$, $V_{DD} = \text{Min}$ $V_{OH} = 2.52\text{V}$, $V_{DD} = \text{Max}$	--	-36	--	--	mA
Low Level Output Current	I_{OL3}	I_{OL3} Response $V_{OH} = 1.80\text{V}$, $V_{DD} = \text{Min}$ $V_{OL} = 2.52\text{V}$, $V_{DD} = \text{Max}$	--	48	--	--	mA
Pull-up Resistance**	R_{PU}	$V_I = 0\text{V}$	Type 1	20	50	(100) 120	$\text{K}\Omega$
			Type 2	40	100	(200) 240	
Pull-down Resistance**	R_{PD}	$V_I = V_{DD}$	Type 1	20	50	(100) 120	$\text{K}\Omega$
			Type 2	40	100	(200) 240	
High Level Maintenance Current	I_{BHH}	Bus Hold Response, $V_{IN} = 2.0\text{V}$, $V_{DD} = \text{Min}$		--	--	-20	μA
Low Level Maintenance Current	I_{BHL}	Bus Hold Response, $V_{IN} = 0.8\text{V}$, $V_{DD} = \text{Min}$		--	--	17	μA
High Level Reversal Current	I_{BHHO}	Bus Hold Response, $V_{IN} = 0.8\text{V}$, $V_{DD} = \text{Max}$		-350	--	--	μA
Low Level Reversal Current	I_{BHLO}	Bus Hold Response, $V_{IN} = 2.0\text{V}$, $V_{DD} = \text{Max}$		210	--	--	μA
Input Terminal Capacitance	C_I	$f = 1\text{Mhz}$, $V_{DD} = 0\text{V}$	--	--	10	--	pF
Output Terminal Capacitance	C_O	$f = 1\text{Mhz}$, $V_{DD} = 0\text{V}$	--	--	10	--	pF
Input/Output Terminal Capacitance	C_{IO}	$f = 1\text{Mhz}$, $V_{DD} = 0\text{V}$	--	--	10	--	pF

* The quiescent current is a typical value ($T_j=85^{\circ}\text{C}$) for each master.

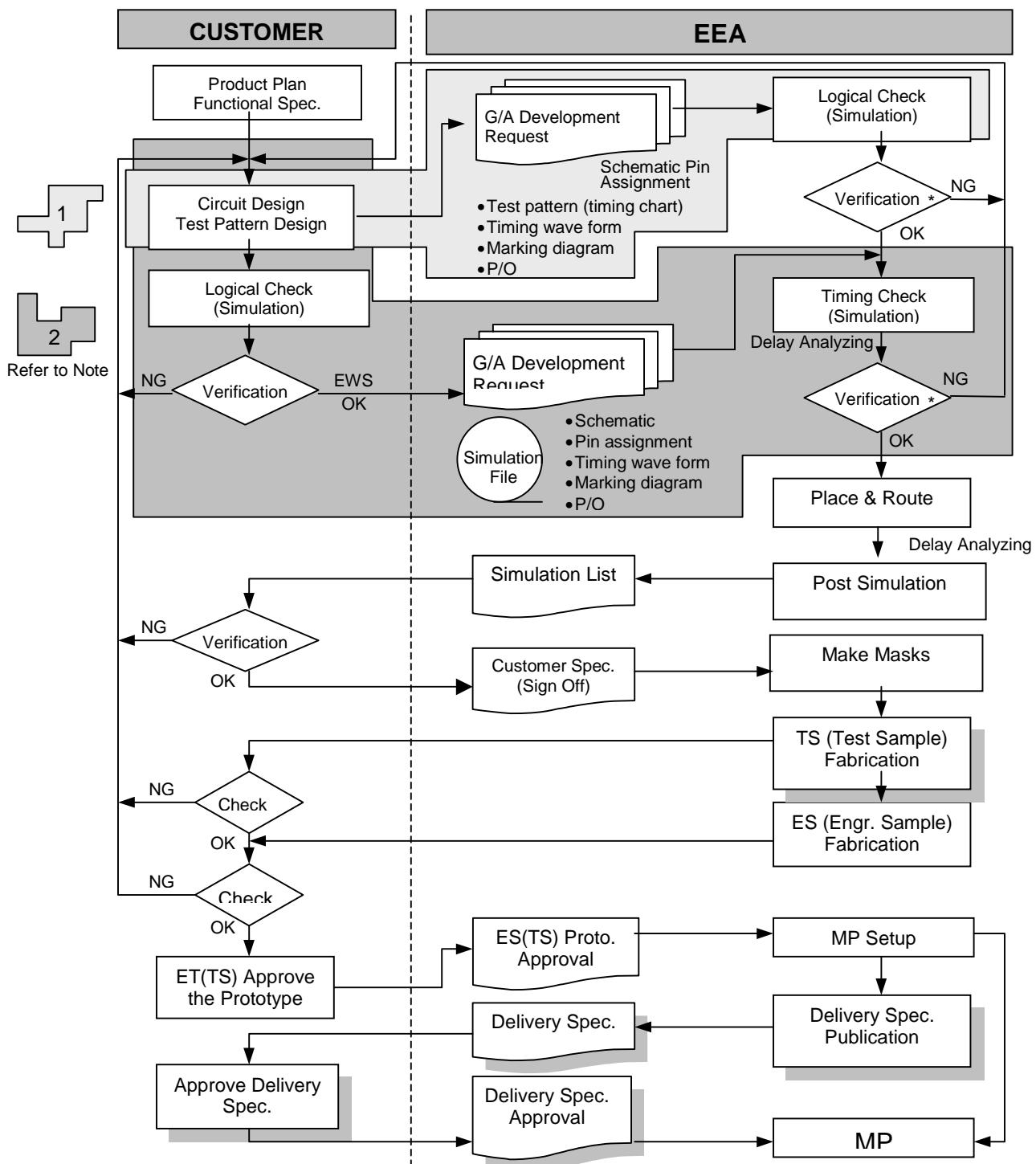
** The values in parentheses are for the case of $T_a = 0$ to 70°C .

Electrical Characteristics of the S1L50000 Series:(V_{DD} = 2.0V ± 0.2V, V_{SS} = 0V, T_a = -40 to 85°C)

Item	Symbol	Conditions		Min	Typ	Max	Unit
Quiescent Current*	I _{DDS}	Quiescent Conditions		--	--	150	µA
Input Leakage Current	I _{LI}	--		-1	--	1	µA
Off State Leakage Current	I _{OZ}	--		-1	--	1	µA
High Level Output Voltage	V _{OH}	I _{OH} = -0.05mA (Type S), -0.3mA (Type M), -0.6mA (Type 1), -2mA (Type 2), -4mA (Type 3, Type 4) V _{DD} = Min	V _{DD} -0.2	--	--	--	V
Low Level Output Voltage	V _{OL}	I _{OL} = 0.05mA (Type S), 0.3mA (Type M), 0.6mA (Type 1), 2mA (Type 2), 4mA (Type 3), 8mA (Type 4) V _{DD} = Min	--	--	0.2	--	V
High Level Input Voltage	V _{IH1}	CMOS Level, V _{DD} = Max		1.6	--	--	V
Low Level Input Voltage	V _{IL1}	CMOS Level, V _{DD} = Min		--	--	0.3	V
High Level Input Voltage	V _{T1+}	CMOS Schmitt		0.4	--	1.6	V
Low Level Input Voltage	V _{T1-}	CMOS Schmitt		0.3	--	1.4	V
Hysteresis Voltage	V _{H1}	CMOS Schmitt		0	--	--	V
Pull-up Resistance	R _{PU}	V _I = 0V	Type 1	30	120	300	KΩ
			Type 2	60	240	600	
Pull-down Resistance	R _{PD}	V _I = V _{DD}	Type 1	30	120	300	KΩ
			Type 2	60	240	600	
High Level Maintenance Current	I _{BHH}	Bus Hold Response, V _{IN} = 1.6V, V _{DD} = Min		--	--	-2	µA
Low Level Maintenance Current	I _{BHL}	Bus Hold Response, V _{IN} = 0.3V, V _{DD} = Min		--	--	2	µA
High Level Reversal Current	I _{BHHO}	Bus Hold Response, V _{IN} = 0.3V, V _{DD} = Max		-100	--	--	µA
Low Level Reversal Current	I _{BHLO}	Bus Hold Response, V _{IN} = 1.6V, V _{DD} = Max		100	--	--	µA
Input Terminal Capacitance	C _I	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF
Output Terminal Capacitance	C _O	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF
Input/Output Terminal Capacitance	C _{IO}	f = 1Mhz, V _{DD} = 0V	--	--	10	--	pF

* The quiescent current is a typical value (T_j=85°C) for each master.

GATE ARRAY DEVELOPMENT FLOW



* Jobs are done by customer and EEA engineer. Steps in shaded boxes are based on customer's requirement.

NOTE: When the customer performs all tasks to the point of logical simulations and delay simulations on engineering workstations, etc., the route taken is (2, Joint Design). When EEA performs the logical simulations, the route taken is (1, Turnkey Design).

■ EEA CUSTOMER ENGINEERING

To help customers implement their design of EEA ASIC's, we offer training at our design centers and at customer sites when required.

When a design is started, an EEA engineer is assigned to the project and will remain with the project through its completion. EEA engineers will work with the customer on design, software and other technical issues. When the design files are transferred to EEA, the assigned engineer will verify the design's integrity and prepare it for place and route. The EEA Customer Engineering Group provides all technical customer-support services including:

- Pre-Sale Technical Support
- Customer Training
- Design Assistance
- Custom Cell Development
- Place and Route
- Scan Insertion and ATPG
- Netlist Conversion and Synthesis
- Software Documentation
- Simulation Support
- Turnkey Design
- Design Verification
- Static Timing Analysis
- JTAG Insertion
- Test Vector Conversion

■ EDA/CAE SUPPORT

- Schematic Capture
 - Viewlogic (Synopsys): Viewdraw
 - EEA: Auklet (ECS)
- Synthesis
 - Synopsys: DesignCompiler
 - Exemplar Logic: Leonardo
- Simulation
 - Cadence: Verilog-XL
 - Synopsys: VSS (VHDL)
 - Avant!: Polaris (Purespeed)
 - Viewlogic (Synopsys): Viewsim
 - Modeltech: V-System (VHDL)
- DFT
 - Synopsys: TestCompiler+
 - Viewlogic (Synopsys): TestGen (Sunrise)
- Place & Route
 - Cadence: GateEnsemble
 - Avant!: Aquarius-GA (Apollo)
- Delay Calculation (Post-Route)
 - EEA: Peacock (EXDT)

■ EDA/CAE SUPPORT (continued)

- Static Timing
 - Synopsys: PrimeTime (DesignTime)
 - Viewlogic (Synopsys): Motive
- Layout Verification
 - Cadence: Dracula/LVS

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